Notice of References Cited Application/Control No. 10/562,410 Examiner SHYAM NATHAN Applicant(s)/Patent Under Reexamination HARLEY ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-2002/0164387	11-2002	Wei et al.	424/746	
*	В	US-2003/0108629	06-2003	Chou, Wen Hsien	424/765	
	С	US-				
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
	Н	US-		- 1		
	1	US-	1			
	J	US-				
	K	US-	1			
	i Lil	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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